

**Notice of References Cited**

Application/Control No.

10/514,411

Applicant(s)/Patent Under

Reexamination

YAMADA ET AL.

Examiner

CONNIE P. JOHNSON

Art Unit

1795

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,916,732	06-1999	Sasashita et al.	430/287.1
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
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H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

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N					
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P					
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R					
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T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	<a href="http://www.agc.co.jp/english/chemicals/shinsei/gel/sun-gel.html">www.agc.co.jp/english/chemicals/shinsei/gel/sun-gel.html</a> (October 9, 1999)
V	Internet Archive, Wayback Machine results for <a href="http://www.agc.co.jp/english/chemicals/shinsei/gel/sun-gel.html">www.agc.co.jp/english/chemicals/shinsei/gel/sun-gel.html</a>
W	<a href="http://www.fuji-silysia.co.jp/english/product/micronized_silica/sylosphere.html">www.fuji-silysia.co.jp/english/product/micronized_silica/sylosphere.html</a> (2003)
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